

Important notice

Dear Customer,

On 7 February 2017 the former NXP Standard Product business became a new company with the tradename **Nexperia**. Nexperia is an industry leading supplier of Discrete, Logic and PowerMOS semiconductors with its focus on the automotive, industrial, computing, consumer and wearable application markets

In data sheets and application notes which still contain NXP or Philips Semiconductors references, use the references to Nexperia, as shown below.

Instead of http://www.nxp.com, http://www.nxp.com, http://www.nexperia.com, http://www.nexperia.com)

Instead of sales.addresses@www.nxp.com or sales.addresses@www.semiconductors.philips.com, use salesaddresses@nexperia.com (email)

Replace the copyright notice at the bottom of each page or elsewhere in the document, depending on the version, as shown below:

- © NXP N.V. (year). All rights reserved or © Koninklijke Philips Electronics N.V. (year). All rights reserved

Should be replaced with:

- © Nexperia B.V. (year). All rights reserved.

If you have any questions related to the data sheet, please contact our nearest sales office via e-mail or telephone (details via **salesaddresses@nexperia.com**). Thank you for your cooperation and understanding,

Kind regards,

Team Nexperia



PBHV8115T

150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

Rev. 02 — 9 December 2008 Product data

Product data sheet

Product profile

1.1 General description

NPN high-voltage low V_{CEsat} Breakthrough In Small Signal (BISS) transistor in a small SOT23 (TO-236AB) Surface-Mounted Device (SMD) plastic package.

PNP complement: PBHV9115T.

1.2 Features

- High voltage
- Low collector-emitter saturation voltage V_{CEsat}
- High collector current capability I_C and I_{CM}
- High collector current gain (h_{FE}) at high I_C
- AEC-Q101 qualified
- Small SMD plastic package

1.3 Applications

- LED driver for LED chain module
- LCD backlighting
- High Intensity Discharge (HID) front lighting
- Automotive motor management
- Hook switch for wired telecom
- Switch Mode Power Supply (SMPS)

1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V_{CEO}	collector-emitter voltage	open base	-	-	150	V
I _C	collector current		-	-	1	Α
h _{FE}	DC current gain	$V_{CE} = 10 \text{ V};$ $I_C = 50 \text{ mA}$	100	250	-	



150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

Pinning information 2.

Table 2 Pinning

Table 2.	Filling		
Pin	Description	Simplified outline	Graphic symbol
1	base		_
2	emitter	3	3
3	collector	1 2	1 —
			sym021

Ordering information 3.

Table 3. **Ordering information**

Type number	Package		
	Name	Description	Version
PBHV8115T	-	plastic surface-mounted package; 3 leads	SOT23

Marking 4.

Table 4. **Marking codes**

Type number	Marking code ^[1]
PBHV8115T	W6*

[1] * = -: made in Hong Kong

* = p: made in Hong Kong

* = t: made in Malaysia

* = W: made in China

2 of 12

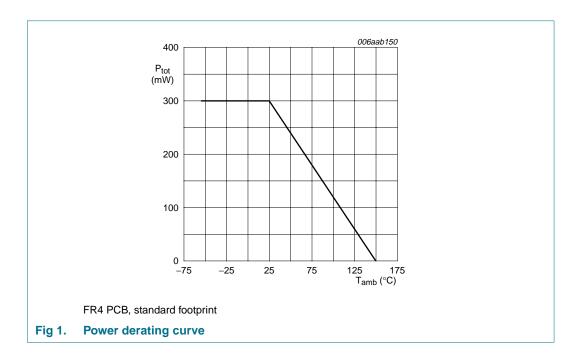
150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

Limiting values

Table 5. **Limiting values** In accordance with the Absolute Maximum Rating System (IEC 60134).

SymbolParameterConditionsMinMaxUnVCBOcollector-base voltageopen emitter-400VVCEOcollector-emitter voltageopen base-150VVEBOemitter-base voltageopen collector-6VIccollector current-1AICMpeak collector currentsingle pulse;-2A	
V _{CEO} collector-emitter voltage open base - 150 V V _{EBO} emitter-base voltage open collector - 6 V I _C collector current - 1 A	nit
V _{EBO} emitter-base voltage open collector - 6 V I _C collector current - 1 A	
I _C collector current - 1 A	
I _{CM} peak collector current single pulse; - 2 A	
$t_p \le 1 \text{ ms}$	
l_{BM} peak base current single pulse; - 400 m/s $t_p \leq 1 \text{ ms}$	4
P_{tot} total power dissipation $T_{amb} \le 25 ^{\circ}C$ [1] - 300 m ¹	N
T_{j} junction temperature - 150 °C	
T _{amb} ambient temperature –55 +150 °C	
T_{stg} storage temperature -65 +150 °C	

Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.



PBHV8115T_2 © NXP B.V. 2008. All rights reserved. Rev. 02 — 9 December 2008

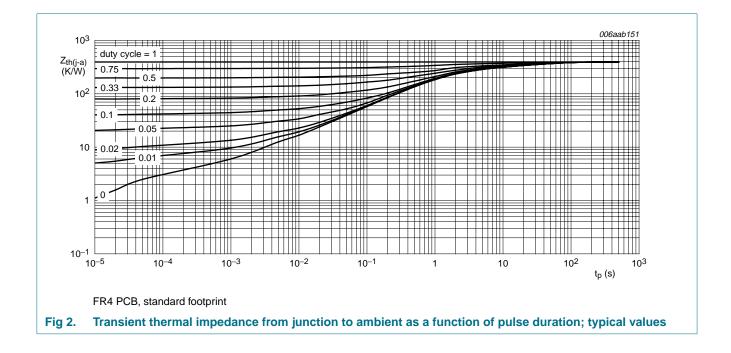
150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

Thermal characteristics 6.

Table 6. **Thermal characteristics**

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$R_{th(j-a)}$	thermal resistance from junction to ambient	in free air	<u>[1]</u> -	-	417	K/W
$R_{th(j-sp)}$	thermal resistance from junction to solder point		-	-	70	K/W

^[1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.



4 of 12

150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

Characteristics 7.

Table 7. Characteristics

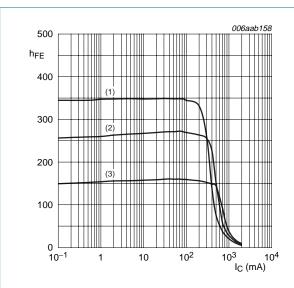
 $T_{amb} = 25 \,^{\circ}C$ unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _{CBO}	collector-base cut-off	$V_{CB} = 120 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
	current	$V_{CB} = 120 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$	-	-	10	μΑ
I _{CES}	collector-emitter cut-off current	$V_{CE} = 120 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	100	nA
I _{EBO}	emitter-base cut-off current	$V_{EB} = 4 \text{ V}; I_{C} = 0 \text{ A}$	-	-	100	nA
h _{FE}	DC current gain	V _{CE} = 10 V				
		$I_C = 50 \text{ mA}$	100	250	-	
		$I_C = 100 \text{ mA}$	100	250	-	
		$I_C = 0.5 A$	<u>[1]</u> 50	160	-	
		I _C = 1 A	<u>11</u> 10	30	-	
V_{CEsat}	collector-emitter saturation voltage	$I_C = 100 \text{ mA}; I_B = 10 \text{ mA}$	-	40	60	mV
		$I_C = 100 \text{ mA}; I_B = 20 \text{ mA}$	-	33	50	mV
		$I_C = 1 A$; $I_B = 200 \text{ mA}$	<u>[1]</u> -	225	350	mV
V _{BEsat}	base-emitter saturation voltage	$I_C = 1 A; I_B = 200 \text{ mA}$	[1] _	1.1	1.2	V
f _T	transition frequency	$V_{CE} = 10 \text{ V}; I_E = 10 \text{ mA};$ f = 100 MHz	-	30	-	MHz
C _c	collector capacitance	$V_{CB} = 20 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	5.7	-	pF
C _e	emitter capacitance	$V_{EB} = 0.5 \text{ V}; I_C = i_c = 0 \text{ A};$ f = 1 MHz	-	150	-	pF
t _d	delay time	$V_{CC} = 6 \text{ V}; I_{C} = 0.5 \text{ A};$	-	7	-	ns
t _r	rise time	$I_{Bon} = 0.1 \text{ A}; I_{Boff} = -0.1 \text{ A}$	-	565	-	ns
t _{on}	turn-on time		-	572	-	ns
ts	storage time		-	1530	-	ns
t _f	fall time		-	700	-	ns
t _{off}	turn-off time		-	2230	-	ns

^[1] Pulse test: $t_p \le 300~\mu s;~\delta \le 0.02.$

5 of 12

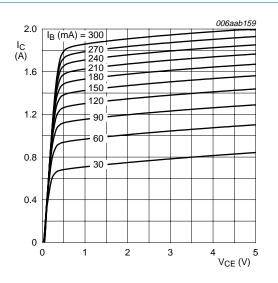
150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor



 $V_{CE} = 10 \text{ V}$

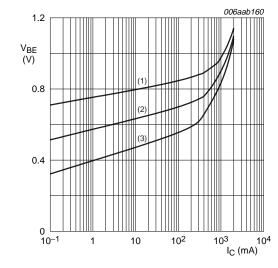
- (1) $T_{amb} = 100 \, ^{\circ}C$
- (2) $T_{amb} = 25 \, ^{\circ}C$
- (3) $T_{amb} = -55 \, ^{\circ}C$

Fig 3. DC current gain as a function of collector current; typical values



 $T_{amb} = 25 \, ^{\circ}C$

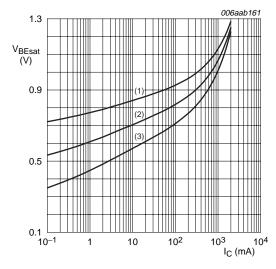
Fig 4. Collector current as a function of collector-emitter voltage; typical values



V_{CE} = 10 V

- (1) $T_{amb} = -55 \,^{\circ}C$
- (2) T_{amb} = 25 °C
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 5. Base-emitter voltage as a function of collector current; typical values



 $I_{\rm C}/I_{\rm B}=5$

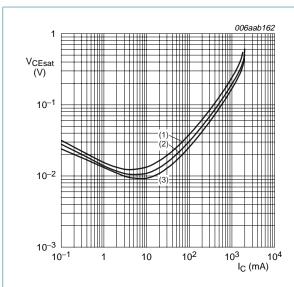
- (1) $T_{amb} = -55 \, ^{\circ}C$
- (2) $T_{amb} = 25 \,^{\circ}C$
- (3) $T_{amb} = 100 \, ^{\circ}C$

Fig 6. Base-emitter saturation voltage as a function of collector current; typical values

6 of 12

PBHV8115T_2 © NXP B.V. 2008. All rights reserved.

150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor



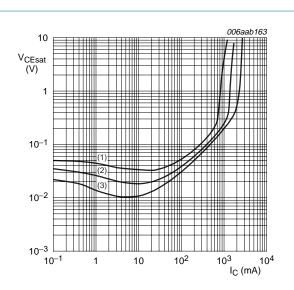
$$I_{\rm C}/I_{\rm B}=5$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2)
$$T_{amb} = 25 \, ^{\circ}C$$

(3) $T_{amb} = -55 \,^{\circ}C$

Fig 7. Collector-emitter saturation voltage as a function of collector current; typical values

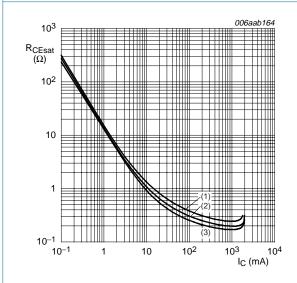


(1)
$$I_C/I_B = 20$$

(2)
$$I_C/I_B = 10$$

(3) $I_C/I_B = 5$

Fig 8. Collector-emitter saturation voltage as a function of collector current; typical values



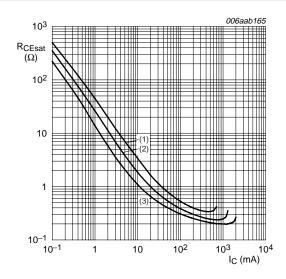
$$I_{\rm C}/I_{\rm B}=5$$

(1)
$$T_{amb} = 100 \, ^{\circ}C$$

(2) $T_{amb} = 25 \, ^{\circ}C$

(3) $T_{amb} = -55 \, ^{\circ}C$

Fig 9. Collector-emitter saturation resistance as a function of collector current; typical values



(1)
$$I_C/I_B = 20$$

(2) $I_C/I_B = 10$

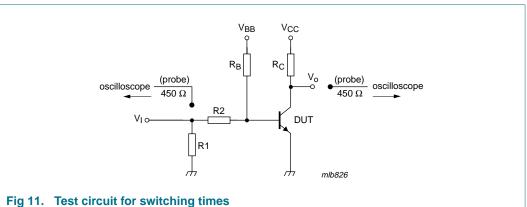
(3) $I_C/I_B = 5$

Fig 10. Collector-emitter saturation resistance as a function of collector current; typical values

PBHV8115T_2 © NXP B.V. 2008. All rights reserved.

150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

8. Test information

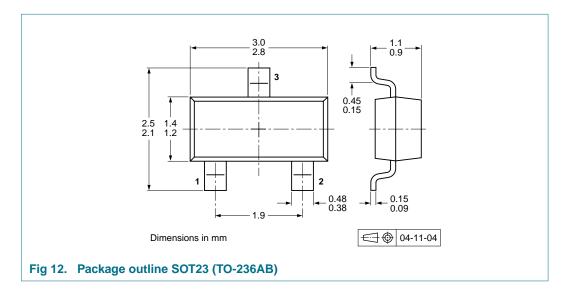


rig 11. Test circuit for switching till

8.1 Quality information

This product has been qualified in accordance with the Automotive Electronics Council (AEC) standard *Q101 - Stress test qualification for discrete semiconductors*, and is suitable for use in automotive applications.

9. Package outline



10. Packing information

Table 8. Packing methods

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

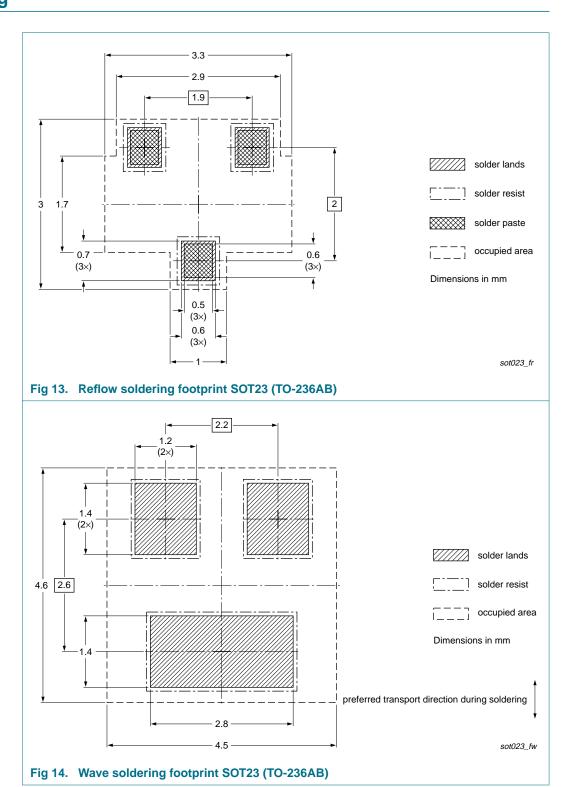
Type number	Package	Description	Packing quantity	
			3000	10000
PBHV8115T	SOT23	4 mm pitch, 8 mm tape and reel	-215	-235

^[1] For further information and the availability of packing methods, see Section 14.

PBHV8115T_2 © NXP B.V. 2008. All rights reserved.

150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

11. Soldering



PBHV8115T_2 © NXP B.V. 2008. All rights reserved.



150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

12. Revision history

Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBHV8115T_2	20081209	Product data sheet	-	PBHV8115T_1
Modifications:	• Figure 4: am	maximum value changed from nended Legal information": updated	m 100 mA to 400 mA	
PBHV8115T_1	20080204	Product data sheet	-	-

150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

13. Legal information

13.1 **Data sheet status**

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- The term 'short data sheet' is explained in section "Definitions"
- The product status of device(s) described in this document may have changed since this document was published and may differ in case of multiple devices. The latest product status information is available on the Internet at URL http://www.nxp.com

Definitions 13.2

Draft — The document is a draft version only. The content is still under internal review and subject to formal approval, which may result in modifications or additions. NXP Semiconductors does not give any representations or warranties as to the accuracy or completeness of information included herein and shall have no liability for the consequences of use of such information.

Short data sheet — A short data sheet is an extract from a full data sheet with the same product type number(s) and title. A short data sheet is intended for quick reference only and should not be relied upon to contain detailed and full information. For detailed and full information see the relevant full data sheet, which is available on request via the local NXP Semiconductors sales office. In case of any inconsistency or conflict with the short data sheet, the full data sheet shall prevail.

13.3 **Disclaimers**

General — Information in this document is believed to be accurate and reliable. However, NXP Semiconductors does not give any representations or warranties, expressed or implied, as to the accuracy or completeness of such information and shall have no liability for the consequences of use of such

Right to make changes — NXP Semiconductors reserves the right to make changes to information published in this document, including without limitation specifications and product descriptions, at any time and without notice. This document supersedes and replaces all information supplied prior to the publication hereof.

Suitability for use — NXP Semiconductors products are not designed, authorized or warranted to be suitable for use in medical, military, aircraft, space or life support equipment, nor in applications where failure or malfunction of an NXP Semiconductors product can reasonably be expected to result in personal injury, death or severe property or environmental

damage. NXP Semiconductors accepts no liability for inclusion and/or use of NXP Semiconductors products in such equipment or applications and therefore such inclusion and/or use is at the customer's own risk.

Applications — Applications that are described herein for any of these products are for illustrative purposes only. NXP Semiconductors makes no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Limiting values — Stress above one or more limiting values (as defined in the Absolute Maximum Ratings System of IEC 60134) may cause permanent damage to the device. Limiting values are stress ratings only and operation of the device at these or any other conditions above those given in the Characteristics sections of this document is not implied. Exposure to limiting values for extended periods may affect device reliability.

Terms and conditions of sale — NXP Semiconductors products are sold subject to the general terms and conditions of commercial sale, as published at http://www.nxp.com/profile/terms, including those pertaining to warranty, intellectual property rights infringement and limitation of liability, unless explicitly otherwise agreed to in writing by NXP Semiconductors. In case of any inconsistency or conflict between information in this document and such terms and conditions, the latter will prevail.

No offer to sell or license — Nothing in this document may be interpreted or construed as an offer to sell products that is open for acceptance or the grant, conveyance or implication of any license under any copyrights, patents or other industrial or intellectual property rights.

Quick reference data — The Quick reference data is an extract of the product data given in the Limiting values and Characteristics sections of this document, and as such is not complete, exhaustive or legally binding.

13.4 Trademarks

Notice: All referenced brands, product names, service names and trademarks are the property of their respective owners.

11 of 12

14. Contact information

Product data sheet

Downloaded from Arrow.com.

For more information, please visit: http://www.nxp.com

For sales office addresses, please send an email to: salesaddresses@nxp.com

PBHV8115T 2 © NXP B.V. 2008. All rights reserved. Rev. 02 — 9 December 2008

150 V, 1 A NPN high-voltage low V_{CEsat} (BISS) transistor

15. Contents

1	Product profile
1.1	General description
1.2	Features
1.3	Applications
1.4	Quick reference data
2	Pinning information 2
3	Ordering information
4	Marking 2
5	Limiting values 3
6	Thermal characteristics 4
7	Characteristics 5
8	Test information
8.1	Quality information
9	Package outline 8
10	Packing information 8
11	Soldering 9
12	Revision history
13	Legal information
13.1	Data sheet status
13.2	Definitions 11
13.3	Disclaimers
13.4	Trademarks11
14	Contact information 11
15	Contents

Please be aware that important notices concerning this document and the product(s) described herein, have been included in section 'Legal information'.

© NXP B.V. 2008.

All rights reserved.

For more information, please visit: http://www.nxp.com For sales office addresses, please send an email to: salesaddresses@nxp.com

Date of release: 9 December 2008 Document identifier: PBHV8115T_2

